## **AMENDMENTS TO THE CLAIMS**

1. (Currently Amended) A method comprising:
over an area of a substrate, forming a plurality of three dimensional first structures;

following forming the first structures, conformally introducing a sacrificial material over the area of the substrate <u>including on a portion of the plurality of first structures</u>;

introducing a second structural material over the sacrificial material; exposing a portion of the sacrificial material; removing the sacrificial material; and

wherein removing the sacrificial material comprises suspending the second structural material as a second structure electrically coupled to the first structure.

## 2. (Canceled)

- 3. (Previously Amended) The method of claim 1, wherein exposing a portion of the sacrificial material comprises removing a portion of the second structural material. comprises removing a portion of the second structural material.
- 4. (Original) The method of claim 1, prior to introducing the second structural material, further comprising patterning the sacrificial material.
- 5. (Original) The method of claim 1, wherein the first structural material comprises silicon and the sacrificial material comprises silicon dioxide and introducing the sacrificial material comprises growing.

## 6. Canceled

7. (Original) The method of claim 1, wherein patterning the first structures defines a plurality of first areas of the portion of the substrate occupied by the first structures and at least a second area of the portion of the substrate free of the first

2

42P10606

structures, and introducing the sacrificial material comprises introducing the sacrificial material at least over the second area.

8. (Currently Amended) A method comprising:

over an area of a surface of a substrate, lithographically patterning a plurality of first structures, the plurality of first structures having a first dimension about the surface of the substrate and a second different dimension;

following forming the <u>plurality of</u> first structures, conformally introducing a sacrificial material layer over the area of the substrate <u>including on a portion of the plurality of first structures</u>;

patterning the sacrificial material;

forming second structures over the sacrificial material;

removing the sacrificial material; and

wherein removing the sacrificial material comprises suspending the second structure by the first structure, and wherein the second structure is electrically coupled to the first structure.

- 9. (Canceled)
- 10. (Original) The method of claim 8, prior to removing the sacrificial material, further comprising exposing a portion of the sacrificial material.
- 11. (Previously Amended) The method of claim 10, wherein exposing a portion of the sacrificial material comprises removing a portion of the second structural material.
- 12. (Original) The method of claim 8, wherein the sacrificial material comprises silicon dioxide and introducing the sacrificial material comprises growing.

3

- 13. (Canceled)
- 14. (Canceled)

42P10606

- 15. (Canceled)
- 16. (Canceled)
- 17. (Canceled)